

LIST OF REFERENCES CITED BY APPLICANT <i>(Use several sheets if necessary)</i>				ATTY. DOCKET NO.:		APPLICATION NO.:			
				4717-8300		10/750 443			
				APPLICANT:					
				Eric NEYRET et al.					
				FILING DATE:		GROUP:			
						2818			
U.S. PATENT DOCUMENTS									
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILED DATE IF APPROPRIATE		
P.D	AA	5,374,564	12/1994	Bruei	437	24	—		
Pb	AB	6,171,965	1/2001	Kang et al.	438	695	—		
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							YES	NO	
PD	AE	FR 2777115 (with English abstract)	10/1999	France	—	—	X		
	AF	FR 2797713 (with English abstract)	2/2001	France	—	—	X		
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	AH	WO 01/28000 (with English abstract)	4/2001	PCT	—	—	X		
	AI	EP 1045448	10/2000	Europe	—	—			
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, Etc.)									
EXAMINER					DATE CONSIDERED				
PHUCT. DANG					2/8/05				
<small>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>									